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# FCMT299N60 N-Channel SuperFET<sup>®</sup> II MOSFET

600 V, 12 A, 299 m $\Omega$ 

## Features

- 650 V @ T<sub>J</sub> = 150°C
- R<sub>DS(on)</sub> = 250 mΩ (Typ.)
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 39 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 127 pF)
- 100% Avalanche Tested
- RoHS Compliant

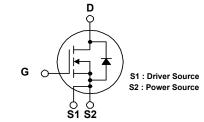
# Applications

- Server and Telecom Power Supplies
- Solar Inverters
- Adaptors

# Description

SuperFET<sup>®</sup> II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as server/telecom power, adaptor and solar inverter applications.

The Power88 package is an ultra-slim surface-mount package (1 mm high) with a low profile and small footprint (8x8 mm<sup>2</sup>). SuperFET II MOSFET in a Power88 package offers excellent switching performance due to lower parasitic source inductance and separated power and drive sources. Power88 offers Moisture Sensitivity Level 1 (MSL 1).



Absolute Maximum Ratings  $T_C = 25^{\circ}C$  unless otherwise noted.

Power88

Symbol	Parameter			FCMT299N60	Unit	
V <sub>DSS</sub>	Drain to Source Voltage		600	V		
V <sub>GSS</sub>	Gate to Source Voltage	-DC		±20	V	
		-AC	(f > 1 Hz)	±30	V	
ID	Drain Current	-Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)		12	Α	
		-Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		7.9		
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		36	А	
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		234	mJ		
I <sub>AR</sub>	Avalanche Current (Note 1)		2.5	Α		
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		1.25	mJ		
dv/dt	Peak Diode Recovery dv/dt (Note 3)			20	V/ns	
	MOSFET dv/dt			100	V/ns	
P <sub>D</sub>	Deven Dissingtion	(T <sub>C</sub> = 25°C)		125	W	
	Power Dissipation	- Derate above 25°C		1	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		econds	300	°C	

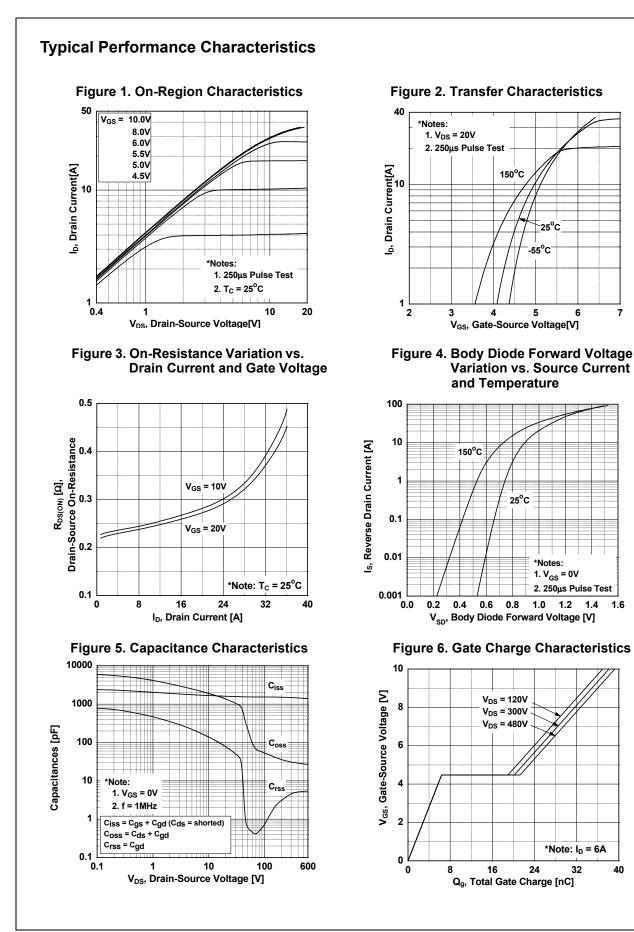
## Thermal Characteristics

Symbol	Parameter	FCMT299N60	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max. 1.0			
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient (* 1 in <sup>2</sup> pad of 2 oz copper), Max.	45	°C/W	

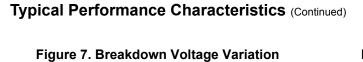
	Device	Packag	e Ree	l Size	Tape Wid	th	Quanti	ity
N60	Device Marking         Device         Pac           FCMT299N60         FCMT299N60         Pow		8	-	-		3000	
Chara	acteristics T <sub>C</sub> = 25°C	Cunless off	erwise noted					
	Parameter			ditions	Min.	Tvp.	Max.	Unit
eristics						51		
			$V_{GS} = 0 \text{ V}, I_{D} = 10 \text{ mA}, T_{C} = 25^{\circ}\text{C}$ $V_{GS} = 0 \text{ V}, I_{D} = 10 \text{ mA}, T_{C} = 150^{\circ}\text{C}$ $I_{D} = 10 \text{ mA}, \text{ Referenced to } 25^{\circ}\text{C}$		C 600	-	-	v
		e V			°C 650	50 -	-	v
Breakdown Voltage Temperature Coefficient					-	0.67	-	V/ºC
Zero Gat	e Voltage Drain Current				-	-	1	μA
Gate to E					- 5°C	-	- ±100	nA
			<u>GS, DS</u>					
	0				2.5	-	3.5	V
					-		0.299	Ω
Forward	Iransconductance	V	$_{\rm DS} = 20$ V, $I_{\rm D} = 67$	4	-	12	-	S
aracte	ristics							
Input Ca	pacitance	V			-	1465	1948	pF
Output C	apacitance			-	30	40	pF	
Reverse	e Output Capacitance				-	4.87	-	pF
			$V_{DS}$ = 0 V to 480 V, $V_{GS}$ = 0 V		-	127	-	pF
Total Gat			V <sub>DS</sub> = 380 V, I <sub>D</sub> = 6 A			39	51	nC
		V <sub>GS</sub> = 10 V		-	6	-	nC	
	v		, ,				-	nC
Equivale	nt Series Resistance	f	= 1 MHz		-	0.8	-	Ω
haract	eristics							
Turn-On	Delay Time			-	19	48	ns	
Turn-On			$V_{DD} = 380 \text{ V}, \text{ I}_{D} = 6 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 4.7 \Omega$		-	9	28	ns
Turn-Off					-	51	112	ns
Turn-Off	Fall Time			(No	ote 4) -	7	24	ns
e Diod	e Characteristics							
Maximum	Continuous Drain to Sour	rce Diode F	orward Current		-	-	12	Α
Maximum					-	-	36	Α
Drain to S			V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 6 A		-	-	1.2	V
Reverse	Recovery Time		$V_{GS} = 0 V, I_{SD} = 6 A$ $dI_F/dt = 100 A/\mu s$		-	262	-	ns
Reverse	Recovery Charge				-	3.8	-	μC
	Drain to S Breakdow Coefficiel Zero Gat Gate to E <b>Pristics</b> Gate Thr Static Dra Forward <b>Paractel</b> Input Cap Output C Reverse Effective Total Gat Gate to D Equivaler Turn-On I Turn-On I Turn-Off I Turn-Off I Turn-Off I Turn-Off I Se Diode Maximum Drain to S Reverse I	Pristics Drain to Source Breakdown Voltag Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate to Body Leakage Current Pristics Gate Threshold Voltage Static Drain to Source On Resistar Forward Transconductance Datacteristics Input Capacitance Reverse Transfer Capacitance Effective Output Capacitance Effective Output Capacitance Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Equivalent Series Resistance haracteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Pliode Characteristics Maximum Continuous Drain to Source	Pristics         Drain to Source Breakdown Voltage       V         Breakdown Voltage Temperature       Ic         Coefficient       V         Zero Gate Voltage Drain Current       V         Gate to Body Leakage Current       V         Pristics       V         Gate Threshold Voltage       V         Static Drain to Source On Resistance       V         Forward Transconductance       V         Paracteristics       V         Input Capacitance       V         Qutput Capacitance       V         Effective Output Capacitance       V         Gate to Drain "Miller" Charge       V         Itrm-On Delay Time       V         Turn-On Rise Time       V         Turn-Off Fall Time       V         Baximum Continuous Drain to Source Diode Forward       Voltage         Vaximum Pulsed Drain to Source Diode Forward       V         Reverse Recovery Time       V	PristicsDrain to Source Breakdown Voltage $V_{GS} = 0 \ V, \ I_D = 10 \ mage to the prior to $	peristicsDrain to Source Breakdown Voltage $V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_C = 25^\circ \text{ V}}{V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_C = 150}$ Breakdown Voltage Temperature CoefficientI_D = 10 mA, Referenced to 25°CZero Gate Voltage Drain Current $V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$ Zero Gate Voltage Drain Current $V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$ Zero Gate Voltage Drain Current $V_{GS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$ Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$ Forward Transconductance $V_{DS} = 20 \text{ V}, I_D = 6 \text{ A}$ PristicsInput CapacitanceOutput Capacitance $V_{DS} = 380 \text{ V}, V_{GS} = 0 \text{ V}$ Reverse Transfer Capacitance $V_{DS} = 380 \text{ V}, V_{GS} = 0 \text{ V}$ Total Gate Charge at 10V $V_{DS} = 380 \text{ V}, I_D = 6 \text{ A}$ Gate to Drain "Miller" Charge $V_{OS} = 10 \text{ V}$ Gate to Drain "Miller" Charge $V_{OS} = 10 \text{ V}$ Turn-On Delay Time $V_{DD} = 380 \text{ V}, I_D = 6 \text{ A}$ Turn-Off Delay Time $V_{DD} = 380 \text{ V}, I_D = 6 \text{ A}$ Turn-Off Fall Time $V_{DD} = 380 \text{ V}, I_D = 6 \text{ A}$ Vision Turn-Off Fall Time $V_{OS} = 10 \text{ V}$ Turn-Off Fall Time $V_{GS} = 10 \text{ V}, R_g = 4.7 \Omega$ Turn-Off Fall Time $V_{GS} = 0 \text{ V}, I_{SD} = 6 \text{ A}$ Maximum Continuous Drain to Source Diode Forward CurrentMaximum Pulsed Drain to Source Diode Forward CurrentDrain to Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_{SD} = 6 \text{ A}$	eristicsDrain to Source Breakdown Voltage $V_{GS} = 0 V$ , $I_D = 10 mA$ , $T_C = 25^{\circ}C$ 600Breakdown Voltage Temperature Coefficient $I_D = 10 mA$ , Referenced to $25^{\circ}C$ -Zero Gate Voltage Drain Current $V_{DS} = 600 V$ , $V_{GS} = 0 V$ -Zero Gate Voltage Drain Current $V_{DS} = 600 V$ , $V_{GS} = 0 V$ , $T_C = 125^{\circ}C$ -Gate to Body Leakage Current $V_{GS} = 480 V$ , $V_{GS} = 0 V$ , $T_C = 125^{\circ}C$ -PristicsSate Threshold Voltage $V_{GS} = 10 V$ , $I_D = 6 A$ -Static Drain to Source On Resistance $V_{GS} = 10 V$ , $I_D = 6 A$ -Forward Transconductance $V_{DS} = 380 V$ , $V_{GS} = 0 V$ -Output Capacitance $V_{DS} = 380 V$ , $V_{GS} = 0 V$ -Total Gate Charge at $10V$ $V_{DS} = 380 V$ , $V_{GS} = 0 V$ -Gate to Source Gate Charge $V_{DS} = 380 V$ , $I_D = 6 A$ -Gate to Source Gate Charge $V_{DS} = 10 V$ -Gate to Source Gate Charge $V_{CS} = 10 V$ -Turn-On Rise Time $V_{DD} = 380 V$ , $I_D = 6 A$ -Turn-On Delay Time $V_{DD} = 380 V$ , $I_D = 6 A$ -Turn-Off Fall Time $V_{DD} = 380 V$ , $I_D = 6 A$ -Turn-Off Fall Time $V_{OS} = 10 V$ , $R_g = 4.7 \Omega$ -Turn-Off Fall Time $V_{CS} = 0 V$ , $I_{SD} = 6 A$ -Turn-Off Fall Time $V_{CS} = 0 V$ , $I_{SD} = 6 A$ -Turn-Off Fall Time $V_{CS} = 0 V$ , $I_{SD} = 6 A$ -Turn-Off Fall Time $V_{CS} = 0 V$ , $I_{SD} = 6 A$ -Turn-Off Fall Ti	PristicsDrain to Source Breakdown Voltage $V_{GS} = 0 V, I_D = 10 \text{ mA}, T_C = 25^\circ C$ $600$ $ V_{GS} = 0 V, I_D = 10 \text{ mA}, T_C = 150^\circ C$ $650$ $-$ Breakdown Voltage Temperature Coefficient $I_D = 10 \text{ mA}, \text{Referenced to } 25^\circ C$ $ 0.67$ Zero Gate Voltage Drain Current $V_{DS} = 600 V, V_{GS} = 0 V$ $  V_{DS} = 480 V, V_{GS} = 0 V, V_{CS} = 125^\circ C$ $ 1.2$ Gate to Body Leakage Current $V_{GS} = 120 V, V_{DS} = 0 V$ $ -$ Pristics $V_{GS} = V_{DS}, I_D = 250 \mu A$ $2.5$ $-$ Gate Threshold Voltage $V_{GS} = 10 V, I_D = 6 A$ $ 0.25$ Forward Transconductance $V_{DS} = 380 V, V_{GS} = 0 V$ $ 1465$ Output Capacitance $V_{DS} = 380 V, V_{GS} = 0 V$ $ 1465$ Output Capacitance $V_{DS} = 380 V, V_{GS} = 0 V$ $ 1465$ Gate to Drain "Miller" Charge $V_{CS} = 10 V$ $ 1445$ Effective Output Capacitance $V_{DS} = 380 V, I_D = 6 A$ $ 30$ Reverse Transfer Capacitance $V_{SS} = 10 V$ $ 14$ Equivalent Series Resistance $f = 1 \text{ MHz}$ $ 0.8$ haracteristicsTurn-On Delay Time $V_{OS} = 10 V, R_g = 4.7 \Omega$ $ 19$ Turn-On Delay Time $V_{CS} = 10 V, R_g = 4.7 \Omega$ $ 19$ Turn-Off Fall Time $V_{OS} = 0 V, I_S = 6 A$ $ -$ Turn-Off Fall Time $V_{GS} = 0 V, I_S = 6 A$ $ -$ <	Pristics         V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>C</sub> = 25°C         600         -         -           Drain to Source Breakdown Voltage         V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>C</sub> = 150°C         650         -         -           Breakdown Voltage Temperature         I <sub>D</sub> = 10 mA, Referenced to 25°C         -         0.67         -           Coefficient         V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V         -         -         1           Zero Gate Voltage Drain Current         V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V         -         -         1           Gate to Body Leakage Current         V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V         -         -         ±100           Pristics         Gate Threshold Voltage         V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 µA         2.5         -         3.5           Static Drain to Source On Resistance         V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6 A         -         0.25         0.299           Forward Transconductance         V <sub>DS</sub> = 380 V, V <sub>GS</sub> = 0 V         -         1465         1948           Output Capacitance         V <sub>DS</sub> = 0 V to 480 V, V <sub>GS</sub> = 0 V         -         127         -           Reverse Transfer Capacitance         V <sub>DS</sub> = 0 V to 480 V, V <sub>GS</sub> = 0 V         -         127         -           Gate to Source Gate Charge         V <sub>GS</sub> = 10 V         -         4.87         -

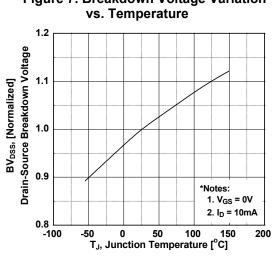
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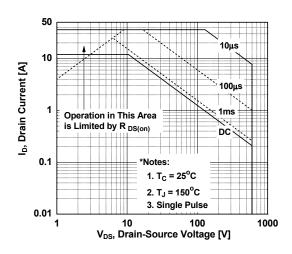


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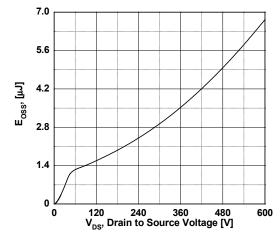


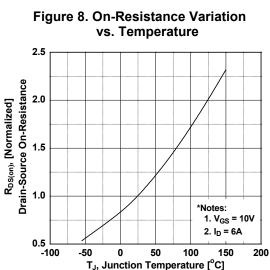


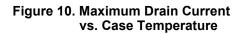


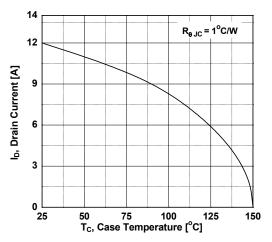


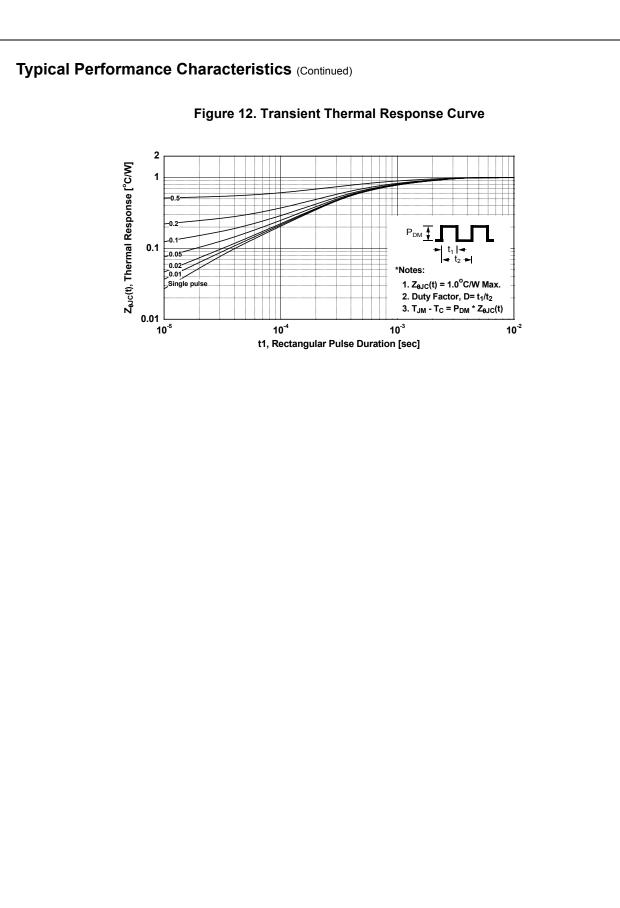


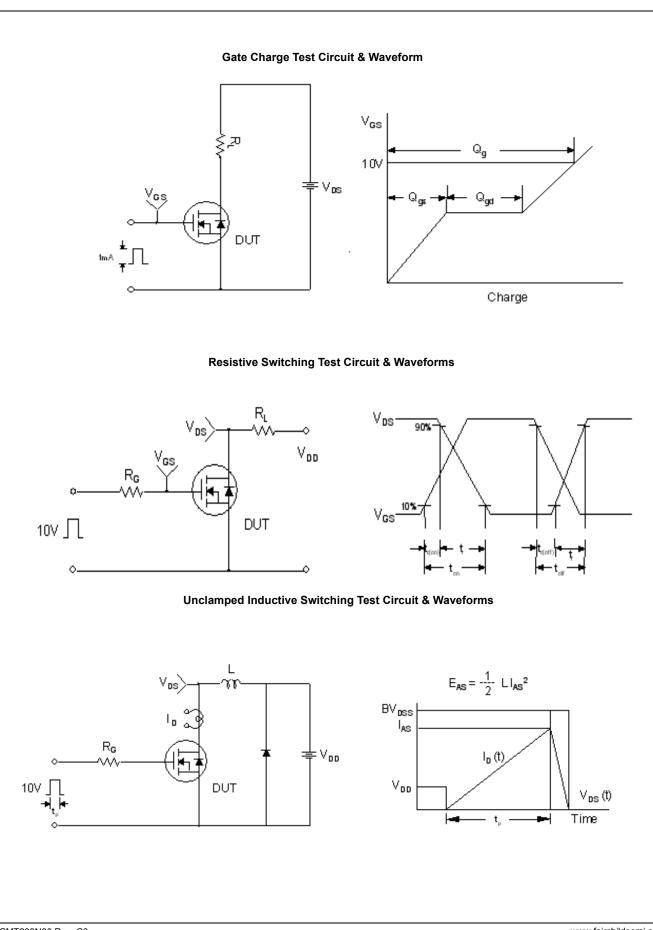




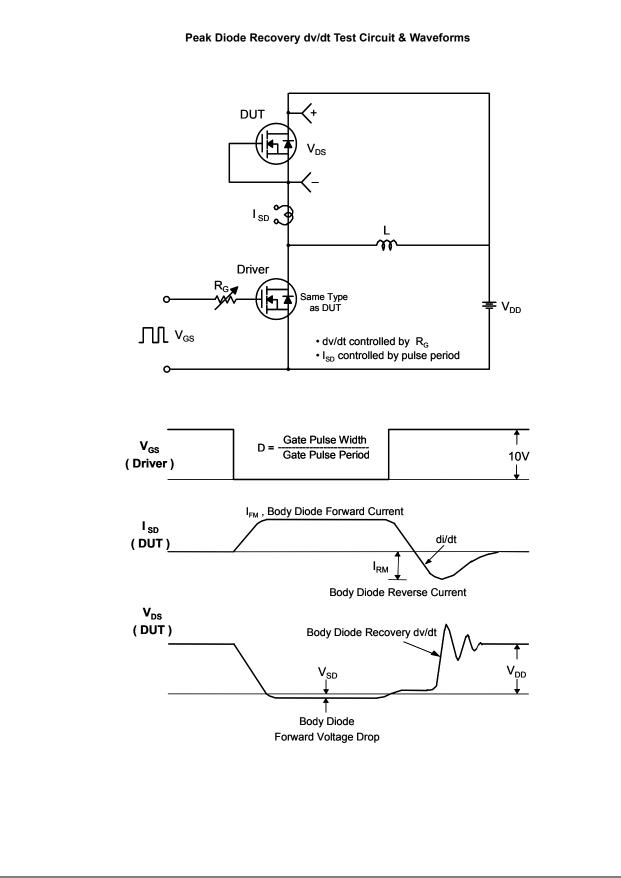








FCMT299N60 — N-Channel SuperFET<sup>®</sup> II MOSFET



8.00 ○ 0.10 C 2X 7.20 AB 8.00 **KEEP OUT** AREA 4.35 1.20 PKG 8.00 Ģ TYP 2.65 **PIN #1** IDENT 0.85 4 1 c2.00 TYP ○ 0.10 C 1 PKG 4 6.00 q 2X LAND PATTERN TOP VIEW RECOMMENDATION 0.30 0.10 SEE DETAIL A 1.10 FRONT VIEW 0.90 C 0.05 0.00 0.10 C A B SEATING 6.00 \$ .05M C PLANE DETAIL A 1.05 2.00 0.85 SCALE: 2X 0.60 (4X) 0.40 4 2.85 **PIN #1** NOTES: UNLESS OTHERWISE SPECIFIED IDENT A) THIS PACKAGE IS NOT PRESENTLY REGISTERED WITH ANY STANDARDS COMMITTEE 4.45 B) DIMENSIONS ARE INCLUSIVE OF BURRS, (3.10)MOLD FLASH, AND TIE BAR PROTRUSIONS. C) ALL DIMENSIONS ARE IN MILLIMETERS. D) DRAWING CONFORMS TO ASME (1.03)Y14.5M-1994 E) DRAWING FILENAME: MKT-PQFN04AREV1 7.30 7.10 BOTTOM VIEW

### Figure 17. Molded Package, Power88, 4 Lead

Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a Fairchild Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide terms and conditions, specifically the warranty therein, which covers Fairchild products.

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Product Status	Definition		
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First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.		
Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.		
Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.		
-	Formative / In Design First Production Full Production		

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